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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10655946 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>XIE ET AL. |
|  | <b>Examiner</b><br><br>Sherman, Stephen G      | <b>Art Unit</b><br><br>2629                                      |

| SEARCHED |                   |            |          |
|----------|-------------------|------------|----------|
| Class    | Subclass          | Date       | Examiner |
| 178      | 18.11,18.09,19.05 | 11/29/2006 | SS       |
| 345      | 175-180,166,      | 11/29/2006 | SS       |
| 382      | 314               | 11/29/2006 | SS       |

| SEARCH NOTES                          |            |          |
|---------------------------------------|------------|----------|
| Search Notes                          | Date       | Examiner |
| See attached search history           |            |          |
| Search Updated                        | 11/29/2006 | SS       |
| Search Updated                        | 9/6/2007   | SS       |
| Search Updated                        | 2/4/2008   | SS       |
| Search Updated                        | 5/6/2008   | SS       |
| NPL Document Search (ACM,iEEE,INSPEC) | 5/6/2008   | SS       |

| INTERFERENCE SEARCH |                             |          |          |
|---------------------|-----------------------------|----------|----------|
| Class               | Subclass                    | Date     | Examiner |
| 178                 | 18.11,18.09,19.05           | 5/6/2008 | SS       |
| 345                 | 175-180,166                 | 5/6/2008 | SS       |
|                     | See attached search history |          |          |